

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/829,115	CHANG ET AL.	
Examiner	Art Unit	
Nitin Parekh	2811	į

SEARCHED					
Class	Subclass	Date	Examiner		
257	737,738	3/2/2005	NP		
	778,780				
	787				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
DATE	EXMR				
3/2/2005	NP				
	DATE 3/2/2005				